Statistical Process Control

Kvalitetsflow 2015

Suggested Program

Day 1		
08.00-09.50	8.00-8.30	Welcome – Presentation and introduction
	8.30-8.55	Over view of SPC – The basics
	9.00 – 9.50	The reason for SPC – flow chart Variation
Coffee		
10.1012.10	10.10-11.00	SPC – Cpk – Six Sigma – short discussion
	11.05-12.10	What type of chart in different situations
Lunch		
12.40-15.00	12.45-13.15	Setting up SPC Systems
	13.20-14.15	Checklist : Ready to measure ?
	14.20-14.40	Discussion – What do need the most ?
	14.50-15.00	Planning for day 2

Suggested Program

Day 2		
08.00-09.50	8.00-8.30	Setting up SPC in QDA
	8.30-8.55	Make QDA fit to your data
	9.00 - 9.50	Case: try it on your data
Coffee	•	
10.1012.10	10.10-11.00	Case: try it on your data
	11.05-12.10	Analysis and reporting
Lunch		
12.40-15.00	12.45-13.15	Analysis and reporting
	13.20-14.15	Additional theory?
	14.20-14.40	Analysis on your data – setting up reports
	14.50-15.00	Evaluation and actions agreed

Training in SPC and Setting up SPC in QDA

Setting up a SPC in general

- Proces variables how to find the relation between the proces variables and our SPC measure system.
- First things first MSA (Measure system analysis) to approve the system before we collect all data make decision on "shaky ground"
- Collecting basic information about the proces
 - USL, LSL
 - UCL, LCL
 - CP and Cpk values and targets

Setting up SPC i QDA

Eavoritae	Statistic Methods			Numbe
	Table Details			
Configuration 📎	Statistical Method Standard			
Administration 🙁	Capabilty (Task/Machine) Capabilty (Gage)	Control Chart Test of Distribution Tools		
er Roles	Process Capability		Machine Capabilty	
ers	-Sigma (Exp.) - Cp	Sigma (Exp.) - Pp	Sigma (Exp.)	
tribution Lists	Sbar/c4	Sbar/c4	S(tot)	
aubation Lists	Rbar/d2	Rbar/d2	🔘 Sbar2	
L-Editor	S(tot)	S(tot)	Rbar2	
atistical Methods	○ Sbar2	Sbar2		
dit I rail	Signa (Evp.) - Cok	Sigma (Evp.) - Pok	◎ Rq/d2	
ations	Shar/c4	 Shar/c4 		
pection Places	Bbar/d2	Bbar/d2		
asurement Categories	S(tot)	Stat)		
calation/Notification	Shar?	Shar2		
ent Manager		0 30412		
	Cp-min 1,66 👻	Pp-min 2 🗸	Cm-min 1 👻	
Master Data 🛛 😵	Cpk-min 1 👻	Ppk-min 1,66 👻	Cmk-min 1,33 👻	
Quality Planning 🛞	+/- sigma 3	+/- sigma 3	+/- sigma 4	
	Additional decimals	- Loa-Cok		
Inspection Pla 😻	Yh 1	Ford		
Data Colloction		🔘 DGQ		
	XDD 2			
Analysis and R 🛞	Sigma 3			
	Capabilty 3			
Document Ma 🛞				
0				



Effect of 1.5 Sigma Process Shift Chart #4 Mean FOUR SIGMA CAPAB



Drift and combinations of PPM and sigma

• part per million.

• Green, indicates data that are normally used

Sigma Drift	3σ	3.5σ	4σ	4.5σ	5σ	5.5σ	6σ
0σ	2,700	465	63	3.4	0.57	0.034	0.002
0.25σ	3,577	666	99	12.8	1.02	0.1056	0.0063
0.5σ	6440	1382	236	32	3.4	0.71	0.019
0.75σ	12228	3011	665	88.5	11	1.02	0.1
1σ	22832	6443	1350	233	32	3.4	0.39
1.25σ	40111	12201	3000	577	88.5	10.7	· 1
1.5σ	66803	22800	6200	1350	233	32	3.4
1.75σ	105601	40100	12200	3000	577	88.4	. 11
2σ	158,700	66800	22800	6200	1300	233	32

Problem Definition



quantitative facts supported by analytical data.



Control Phase

How to create a Control Plan: (one suggestion...)

- Select Causal Variable(s). Proven vital few X(s)
- Define Control Plan
 - 5Ws for optimal ranges of X(s)
- Validate Control Plan
 - Observe Y
- Implement/Document Control Plan
- Audit Control Plan
- Monitor Performance Metrics

Control Phase

Control Plan Tools:

- Statistical Process Control (SPC) Used with various types of distributions Control Charts
 - Attribute based (np, p, c, u). Variable based (X-R, X)
 - Additional Variable based tools
 - -PRE-Control
 - Common Cause Chart (Exponentially Balanced Moving Average (EWMA))

Control Phase

How do we select the correct Control Chart:











Statistical Process Control (SPC)

- Invented by Walter Shewhart at Western Electric
- Distinguishes between
 - o common cause variability (random)
 - special cause variability (assignable)
- Based on repeated samples from a process

Statistical Process Control (SPC)

- A methodology for monitoring a process to identify special causes of variation and signal the need to take corrective action when appropriate
- SPC relies on control charts

 Deviation = distance between observations and the mean (or average)

• Results for "Emmett"

	Observations	Deviations
	10	10 - 8.4 = 1.6
	9	9 - 8.4 = 0.6
	8	8 - 8.4 = -0.4
	8	8 - 8.4 = -0.4
	7	7 - 8 11.4
averages	8.4	0.0



Jake

Deviation = distance between observations and the mean (or average)



• Results for "Jake"

	0.000 / dtiolig
7 - 6.6 = 0.4	7
7 - 6.6 = 0.4	7
7 - 6.6 = 0.4	7
6 - 6.6 = -0.6	6
6 - 6.6 = -0.6	6
0.0	rerages 6.6
	erages 6.6



• Variance = average distance between observations and the mean squared

	Observations	Deviations	Squared Deviations
	10	10 - 8.4 = 1.6	2.56
	9	9 - 8.4 = 0.6	0.36
	8	8 - 8.4 = -0.4	0.16
	8	8 - 8.4 = -0.4	0.16
	7	7 - 8.4 = -1.4	1,96
averages	8.4	0.0	1.0





Jake **– Variance**

• Variance = average distance between observations and the mean squared





	Observations	Deviations	Squared Deviations
	7		
	7		
	7		
	6		
	6		
averages			

• Variance = average distance between observations and the mean squared



7 7 - 6.6 = 0.4 0 7 7 - 6.6 = 0.4 0 7 7 - 6.6 = 0.4 0 6 6 - 6.6 = -0.6 0 6 6 - 6.6 = -0.6 0		Observations	Deviations	Squared Deviations
7 7 - 6.6 = 0.4 0 7 7 - 6.6 = 0.4 0 6 6 - 6.6 = -0.6 0 6 6 - 6.6 = -0.6 0		7	7 - 6.6 = 0.4	0.16
7 7 - 6.6 = 0.4 0 6 6 - 6.6 = -0.6 0 6 6 - 6.6 = -0.6 0		7	7 - 6.6 = 0.4	0.16
6 6 - 6.6 = -0.6 0 6 6 - 6.6 = -0.6 0		7	7 - 6.6 = 0.4	0.16
6 6 - 6.6 = -0.6		6	6 - 6.6 = -0.6	0.36
		6	6 - 6.6 = -0.6	0.36
averages 6.6 0.0 0.	averages	6.6	0.0	0.24



• Standard deviation = square root of variance



	Variance	Standard Deviation
Emmett	1.0	1.0
Jake	0.24	0.4898979



Jake



Here is why:

Even outcomes that are equally likely (like dice), when you add them up, become bell shaped



"Normal" bell shaped curve



Causes of Variability

- Common Causes:
 - Random variation (usual)
 - No pattern
 - Inherent in process
 - adjusting the process increases its variation
- Special Causes
 - Non-random variation (unusual)
 - May exhibit a pattern
 - Assignable, explainable, controllable
 - adjusting the process decreases its variation

3 Sigma and 6 Sigma Quality



Statistical Process Control

• The Control Process

- o Define
- Measure
- Compare
- Evaluate
- Correct
- Monitor results
- Variations and Control
 - Random variation: Natural variations in the output of a process, created by countless minor factors
 - Assignable variation: A variation whose source can be identified

Sampling Distribution







SPC Errors

- Type I error
 - Concluding a process is not in control when it actually is.
- Type II error
 - Concluding a process is in control when it is not.



Observations from Sample Distribution



Control Chart

- Control Chart
 - Purpose: to monitor process output to see if it is random
 - A time ordered plot representative sample statistics obtained from an on going process (e.g. sample means)
 - Upper and lower control limits define the range of acceptable variation
Control Chart



37

Control Charts in General

- Are named according to the statistics being plotted, i.e., X bar, R, p, and c
- Have a center line that is the overall average
- Have limits above and below the center line at ± 3 standard deviations (usually)



Histograms do not take into account changes over time.

	A	39 B	С	D	E	F	G	H			
1	Frequency distribution										
2	2 Upper limit Frequency										
3	0.55	1		Histogram							
4	0.6	1	instogram								
5	0.65	10		50 T							
6	0.7	14		40							
- 7 -	0.75	40	~	40 T			-				
8	0.8	31	Ĕ	30 1							
9	0.85	37	e e	50							
10	0.9	14	D	20 +							
11	0.95	1	L L			_					
12	1	1	-	10 +	-						
13	More	0									
14				0 +	┝╼═┥┤╼═┥┤			╸╷╺╸╷╺	╺┽╾─┤┃		
15	Average	0.762		55	0.0 05	75		6 7 6 7	- e		
16	Std. Dev.	0.0738		Ö) o	Ŭ O `	- o -	í o'	Σ		
17			Bin								
18			Biii								
19											



Control charts can tell us when a process changes

Control Chart Applications

 Establish state of statistical control
 Monitor a process and signal when it goes out of control

• Determine process capability

Commonly Used Control Charts

Variables data
x-bar and R-charts
x-bar and s-charts
Charts for individuals (x-charts)
Attribute data
For "defectives" (p-chart, np-chart)
For "defects" (c-chart, u-chart)

Developing Control Charts

• Prepare

- Choose measurement
- Determine how to collect data, sample size, and frequency of sampling
- Set up an initial control chart
- Collect Data
 - Record data
 - Calculate appropriate statistics
 - Plot statistics on chart



Next Steps

Determine trial control limits
Center line (process average)
Compute UCL, LCL
Analyze and interpret results
Determine if in control
Eliminate out-of-control points
Recompute control limits as necessary

Limits

• Process and Control limits:

- Statistical
- Process limits are used for individual items
- Control limits are used with averages
- Limits = $\mu \pm 3\sigma$
- Define usual (common causes) & unusual (special causes)
- Specification limits:
 - Engineered
 - Limits = target ± tolerance
 - Define acceptable & unacceptable

Process vs. control limits46



• Variance of averages < variance of individual items

Variables Data Charts

- Process Centering
 - X bar chart
 - X bar is a sample mean



- Process Dispersion (consistency)
 - R chart
 - R is a sample range

$$R = \max(X_i) - \min(X_i)$$

X bar charts

- Center line is the grand mean (X double bar)
- $\sigma_{\overline{x}} = \sigma / \sqrt{n} \qquad \overline{\overline{X}} = \frac{\sum_{j=1}^{\infty} \overline{X_j}}{\overline{X_j}}$ • Points are X bars m $LCL = X - z\sigma_{-}$ $UCL = X + z\sigma_{-}$ -OR- $UCL = X + A_2 R$ $LCL = X - A_2 \overline{R}$

R Charts

• Center line is the grand mean (R bar)

• Points are R

D3 and D4 values are tabled according to n (sample size)

$$UCL = D_4 \overline{R} \qquad \qquad LCL = D_3 \overline{R}$$

Use of X bar & R charts

• Charts are always used in tandem

50

- Data are collected (20-25 samples)
- Sample statistics are computed
- All data are plotted on the 2 charts
- Charts are examined for randomness
- If random, then limits are used "forever"

Attribute Charts

 c charts – used to count defects in a constant sample size



 $LCL = \overline{c} - z \sqrt{\overline{c}}$

 $UCL = \overline{c} + z\sqrt{\overline{c}}$

Attribute Charts

 p charts – used to track a proportion (fraction) defective

$$\overline{p} = \frac{\sum_{j=1}^{m} p}{m} = \frac{\sum_{ij} x}{nm} = centerline^{\sum_{i=1}^{n} x_i}$$

$$UCL = \overline{p} + z_{\sqrt{\frac{\overline{p}(1-\overline{p})}{n}}} \qquad LCL = \overline{p} - z_{\sqrt{\frac{\overline{p}(1-\overline{p})}{n}}}$$

Control Charts for Variables

• Mean control charts

- Used to monitor the central tendency of a process.
- X bar charts

• Range control charts

- Used to monitor the process dispersion
- R charts

Variables generate data that are *measured*.





Control Chart for Attributes

- p-Chart Control chart used to monitor the proportion of defectives in a process
- c-Chart Control chart used to monitor the number of defects per unit

Attributes generate data that are *counted*.

Use of p-Charts

• When observations can be placed into two categories.

57

- Good or bad
- Pass or fail
- Operate or don't operate
- When the data consists of multiple samples of several observations each

Use of c-Charts

- Use only when the number of occurrences per unit of measure can be counted; non-occurrences cannot be counted.
 - Scratches, chips, dents, or errors per item
 - Cracks or faults per unit of distance
 - Breaks or Tears per unit of area
 - Bacteria or pollutants per unit of volume
 - Calls, complaints, failures per unit of time

Use of Control Charts

• At what point in the process to use control charts

59

• What size samples to take

- What type of control chart to use
 - Variables
 - Attributes

Run Tests

- Run test a test for randomness
- Any sort of pattern in the data would suggest a non-random process
- All points are within the control limits the process may not be random

Nonrandom Patterns in Control charts

- Trend
- Cycles
- Bias
- Mean shift
- Too much dispersion

Typical Out-of-Control Patterns

Point outside control limits
Sudden shift in process average
Cycles
Trends
Hugging the center line
Hugging the control limits
Instability

Shift in Process Average



Identifying Potential Shifts







Final Steps

Use as a problem-solving tool
Continue to collect and plot data
Take corrective action when necessary
Compute process capability

Process Capability

• Tolerances or specifications

- Range of acceptable values established by engineering design or customer requirements
- Process variability
 - Natural variability in a process
- Process capability
 - Process variability relative to specification



Process Capability Ratio

Process capability ratio, Cp = <u>specification width</u> process width

$Cp = \frac{Upper specification - lower specification}{6\sigma}$

Improving Process Capability

- Simplify
- Standardize
- Mistake-proof
- Upgrade equipment
- Automate


Meet the Guru: Taguchi

Taguchi Quality through design

 Product must bee robust to variation in process
 Loss is equal to distance from nominal



But in reality it looks like this ?

The OK /NOK quality Lower tolerance Upper tolerance 0 0 6 **(a) (a)** 6 🔞 -00 6 6 0 60 6 0 -6 0 6 0 60 **1**

Limitations of Capability Indexes

- Process may not be stable
 Process output may not be normally distributed
- Process not centered but Cp is used

Process Capability



Empirical Rule



77

Gauges and Measuring Instruments

- Variable gauges
- Fixed gauges
- Coordinate measuring machine
- Vision systems



Vernier caliper







Digital caliper



One-inch digital electronic micrometer

Metrology - Science of Measurement

- Accuracy closeness of agreement between an observed value and a standard
- Precision closeness of agreement between randomly selected individual measurements

Repeatability and Reproducibility

- Repeatability (equipment variation) variation in multiple measurements by an individual using the same instrument.
- Reproducibility (operator variation) variation in the same measuring instrument used by different individuals

Repeatability and Reproducibility Studies

- Quantify and evaluate the capability of a measurement system
 - Select m operators and n parts
 - Calibrate the measuring instrument
 - Randomly measure each part by each operator for r trials
 - Compute key statistics to quantify repeatability and reproducibility

Reliability and Reproducibility Studies(2)



Reliability and Reproducibility Studies(3)



Results are in actual units measured. Customary to express as percentages.

Under 10% - Acceptable

10-30% - ? based on importance and repair cost

Over 30% - Unacceptable

R&R Constants

Number of Trials	2	3	4	5
K ₁	4.56	3.05	2.50	2.21
Number of Operators	2	3	4	5
K ₂	3.65	2.70	2.30	2.08

R&R Evaluation

Under 10% error - OK
10-30% error - may be OK
over 30% error - unacceptable











- Outside influences
 Black noise
 Potentially controllable
- How the process is actually performing over time



Fishbone

Common Cause Variation

Variation present in every process
Not controllable
The best the process can be within the present technology

$$\sigma^2_{\text{Total}} = \sigma^2_{\text{Part-Part}} + \sigma^2_{\text{R&R}}$$

Recommendation:

Resolution £ 10% of tolerance to measure Gauge R&R £ 20% of tolerance to measure



• Repeatability (Equipment variation)

• Variation observed with one measurement device when used several times by one operator while measuring the identical characteristic on the same part.

Reproducibility (Appraised variation)

• Variation Obtained from different operators using the same device when measuring the identical characteristic on the same part.

•Stability or Drift

• Total variation in the measurement obtained with a measurement obtained on the same master or reference value when measuring the same characteristic, over an extending time period.



In many cases, the data sample can be transformed so that it is approximately normal. For example, square roots, logarithms, and reciprocals often take a positively skewed distribution and convert it to something close to a bell-shaped curve



94

What do we Need?





Off-Target, Low Variation High Potential Defects Good Cp but Bad Cpk



On Target High Variation **High Potential Defects No so good Cp and Cpk**



LSL



On-Target, Low Variation
Low Potential Defects
Good Cp and Cpk

• Variation reduction and process centering create processes with less potential for defects.

• The concept of defect reduction applies to ALL processes (not just manufacturing)





Statistical Analysis

Apply statistics to validate actions & improvements

Hypothesis Testing





Regression Analysis



- Is the factor really important?
- Do we understand the impact for the factor?
- Has our improvement made an impact
- What is the true impact?



Excercise



Symbol	Beskrivelse	Enhed
X _{max}	Kastelængde	m (meter)
v _o	Begyndelseshastigheden	m s
g	Tyngdeaccelerationen	$g \approx 9,82 \frac{m}{s^2}$
α	Affyringsvinklen	0